

Application No.	Applicant(s)
09/493,083	KAKEHASHI, TAKUYA
Examiner	Art Unit
Quoc A. Tran	2176

	SEARCHED				
Class	Subclass	Date	Examiner		
715	526-530	10/7/2003	QT		
715	505-506	10/7/2003	QT		
715	508	10/7/2003	QT		
715	511	10/8/2003	QT		
707	1	10/7/2003	QT		
update		2/27/2004	QT		
update		10/29/2004	QT		
update		4/8/2005	QT		
715	500, 507	4/8/2005	QT		
			:		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
715	507	4/8/2005	QT	
715	505	4/8/2005	QT	
715	508	4/8/2005	QT	
715/506		4/8/2008	QT	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
inventor searcg check for double patent, US-PAT, US-PGPUB, EPO, JPO, Derwent, IBM_TDB, Internet search, Plus search, EIC	9/30/2003	QT		
Personal Digests	9/30/2003	QT		
update	2/27/2004	QT		
update	10/29/2004	QT		
Consulted with Primary Examiner Sanjiv Shah	10/20/2003	QT		
Consulted with Primary Examiner Sanjiv Shah	4/72005	QT		
Consulted with SPE -TC 2176Joeseph Feild	4/6/2005	QT		